Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/641,141	YEH, CHRIS	
Examiner	Art Unit	
James W. Cranson	2875	

SEARCHED			
Class	Subclass	Date	Examiner
362	109	2/11/2005	JWC
362	253	2/11/2005	JWC
358	474	2/11/2005	JWC
235	462.24	2/11/2005	JWC
235	462.41	2/11/2005	JWC
235	462.45	2/11/2005	JWC
235	462.46	2/11/2005	JWC
<u>.</u> .			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
362/\$	2/11/2005	JWC	
358/\$	2/11/2005	ıwc	
235/\$	2/11/2005	JWC	
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